Notice of References Cited Application/Control No. 10/736,657 Applicant(s)/Patent Under Reexamination LOPEZ-ESTRADA, ALEX A. Examiner Bharadwaj Kalpana Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,292,822	09-2001	Hardwick, Jonathan C.	718/105
*	В	US-2002/0186658	12-2002	Chiu et al.	370/237
*	O	US-2003/0115118	06-2003	Reinemann, Jeffrey K.	705/30
*	۵	US-2003/0217096	11-2003	McKelvie et al.	709/202
*	Е	US-2003/0120780	06-2003	Zhu et al.	709/226
*	F	US-2003/0069924	04-2003	Peart et al.	709/203
*	G	US-2003/0154266	08-2003	Bobick et al.	709/223
*	Н	US-2003/0225867	12-2003	Wedlake, Martine B.	709/222
*	-	US-2003/0172135	09-2003	Bobick et al.	709/220
*	j	US-2003/0074467	04-2003	Oblak et al.	709/238
*	Κ	US-6,615,166	09-2003	Guheen et al.	703/27
	L	US-		·	
	М	US-		·	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

	NON-FAIENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	V						
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	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.